Vertically-oriented few-layer graphene supported by silicon microchannel plates as a counter electrode in dye-sensitized solar cells

Fengjuan Miao, Rui Miao, Bairui Tao, Zaishun Jin, Jianbo Yu, Paul K. Chu, Fang Liu, Lili Shao, Chunmei Li, Xiaodong Zhu

College of Communications and Electronics Engineering, Qiqihar University, Heilongjiang, 161006, China
Modern Education Technology Center, Qiqihar University, Heilongjiang, 161006, China
Department of Physics and Materials Sciences, City University of Hong Kong, Tat Chee Avenue, Kowloon, Hong Kong, China
Mudanjiang Medical College, Heilongjiang, 157011, China

Abstract
Vertically-oriented few-layer graphene supported by silicon microchannel plates annealed at different temperatures are used in dye-sensitized solar cells (DSSCs). The structure, morphology, and electrochemical characteristics are determined by AFM, SEM, XPS, cyclic voltammetry, electrochemical impedance spectroscopy, and photocurrent density-voltage curves. The graphene/Si-MCP fabricated by electrochemical exfoliation delivers enhanced power conversion efficiency in DSSC and the materials annealed under ambient conditions at 300 °C show the best results due to the smaller oxygen concentration in graphene and larger electrical conductance. Owing to the microelectronics-compatible fabrication process and excellent properties of the device, the counter electrode has large potential in high-performance silicon-based monolithic DSSCs.

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1. Introduction
Dye-sensitized solar cells (DSSCs) have aroused tremendous interest due to the low cost, easy fabrication, and high efficiency [1–3]. A typical DSSC consists of three parts, a dye-sensitized TiO2 photoanode, an electrolyte containing a redox couple (I-/I3), and a counter electrode. During operation, I− in the electrolyte is oxidized on the TiO2 photoanode under light illumination and I3− is reduced on the counter electrode. The counter electrode plays an importance role which determines the reduction rate of the I-/I3 redox pair and enables the dye to return from an excited state to the ground state [4,5]. Since the counter electrode should have high reduction activity, platinum (Pt) is typically used due to its high catalytic activity [6]. However, the high cost and scarcity being a noble metal hamper large-scale industrial application and so it is desirable to identify cheaper and more abundant materials with high catalytic activity to substitute for Pt.

Graphene, a one-atom-thick hexagonal mesh structure, has received considerable attention due to its large accessible surface area, high electrochemical activity, and high electronic conductivity. It also has large abundance and good chemical stability and is a viable candidate in counter electrodes in DSSCs [7–10]. However, graphene aggregates easily due to the intrinsic long-range p–p electronic structure giving rise to small surface area and poor catalytic activity. In order to solve this problem, three-dimensional graphene has been proposed. Yu et al. synthesized vertically-oriented graphene as the counter electrode in DSSCs and the materials showed a charge transfer resistance which is about 1% of Pt and improves the power conversion efficiency of DSSCs [11]. Wang et al. developed a graphene sheet with a 3D honeycomb-like structure which delivered good catalytic performance and energy conversion efficiency [12]. However, there has been seldom research to combine graphene and silicon as the electrode in DSSCs.

The silicon microchannel plate (Si-MCP) is a macro-porous and channel-ordered structure with better properties than conventional porous materials and modification of the Si-MCP inner wall with better electrode materials improves the catalytic performance drastically. In this work, a new nanocomposite electrode based on
few-layer graphene supported by 3D silicon MCP is used as the counter electrode in dye-sensitized solar cells. Si-MCP is adopted as the backbone to disperse the few-layer graphene to avoid aggregation and increase the surface-to-volume ratio. The graphene/Si-MCP nanocomposite electrode has a large surface area good chemical stability and the ordered macro-porous structure increases the electrode/electrolyte interfacial area facilitating ion transfer.

2. Experimental details

2.1. Materials and reagents

All the chemical reagents were analytical grade and used as received. Single side polished 100 mm (100) silicon wafers with a resistivity of 2–8 Ω-cm and thickness of 525 μm were used as the starting materials to produce the Si MCPs. Hydrofluoric acid, dimethylformamide, ammonium fluoride, sodium hydroxide, ethanol, and other reagents were used in the reaction. A high-purity graphite rod (6 mm in diameter) was used as the anode, a Pt wire was used as the cathode, and ammonium sulfate was the electrolyte in the two-electrode electrochemical system to produce the few-layer graphene. The aqueous solutions were prepared with 18 MΩ deionized water and all the experiments were carried out at room temperature in a clean environment.

2.2. Preparation of silicon microchannel plates

The Si-MCP was fabricated by traditional microelectronic processing and more details about the fabrication can be found elsewhere [13]. The process included the following main steps: (i) A thick SiO2 layer was grown thermally on the silicon wafer as a mask; (ii) A proper region was obtained on the front side by photolithography and wet etching in buffered hydrofluoric acid; (iii) Pyramidal notches were created for subsequent anodization; (iv) The SiO2 layer was remove; (v) Photo-assisted electrochemical etching was performed at a low temperature. The software Labview was employed to control both current densities and etching time.

2.3. Electrochemical exfoliation of graphene from graphite

In the two-electrode system, the distance between the Pt wire and graphite rod was 2.5 cm. The electrolyte was prepared by dissolving 1.06 g of (NH4)2SO4 in 80 mL of DI water. The electrochemical exfoliation process was carried out by applying +8 V DC for 30 min. The exfoliated graphene sheets in the suspension was collected with 100 nm porous filter and rinsed with DI water by vacuum filtration. After drying, they were dispersed in the DMF solution under gentle sonication for 15 min [14].

2.4. Fabrication of vertically-oriented few-layer graphene supported by silicon microchannel plate

The Si-MCP was dipped in a solution of Triton X-100 30 s to decrease the internal stress and enhance wetting. The graphene solution was stabilized for about 48 h to precipitate un-exfoliated graphite flakes or particles. The top part of the dispersion was used in electrophoresis on the Si-MCP supporter to fabricate the
graphene/Si-MCP counter electrode. The fabrication process of the graphene/Si-MCP counter electrode is illustrated in Fig. 1. The graphene/Si-MCP samples are annealed under ambient conditions at 300 and 500 °C for 1 h to improve the quality [15–18].

2.5. Characterization

The morphology of the few-layer graphene and graphene/Si-MCP were observed by scanning electron microscopy (SEM). Raman scattering was performed on a dispersive Raman microscope spectrometer with an excitation laser wavelength of 532 nm. The chemical composition and bonding states were determined by x-ray photoelectron spectroscopy (XPS).

2.6. Fabrication of DSSC

The DSSC (active area of 0.25 cm²) was assembled according to the following procedures. The TiO₂ electrode was obtained by the sol-gel method on the conducting glass substrate sintered at 500 °C for 30 min in air [19]. The TiO₂ photoelectrode was then dipped in a 0.5 mM solution containing the N₃ dye and ethanol for 12 h at room temperature. The DSSC was assembled by sandwiching the dye-sensitized nanocrystalline TiO₂ electrode and graphene/Si-MCP counter electrode with a 25 μm thick gap. The electrolyte was introduced into the cell by capillary effects through the thin gap between two electrodes. 0.5 M KI/0.05 M I₂, ethylene carbonate (EC), and propylene carbonate (PC) (EC: PC = 1:4 by volume) were the electrolyte. The photovoltaic performance of the graphene/Si-MCP counter electrode was determined under simulated solar illumination (AM 1.5, 100 mW cm⁻²) at 25 °C.

3. Results and discussion

As shown in Fig. 2(a), the few-layer graphene has a rumpling and scrolling morphology. Fig. 2(b) and (c) show the representative AFM image and statistical thickness distribution histograms of the graphene nanosheets. The thickness of 80% measured graphene nanosheets is less than 3 nm and the number of layers is less than 5. Based on the statistical analysis, most of the graphene nanosheets have 2–4 layers and the lateral size is between 50 and 650 nm. Fig. 3 displays the image of Si-MCP fabricated by electrochemical etching. It is a connective film having a diameter of 5 μm. The channels have little impurities and are aligned orderly with a depth of approximately 200 μm. The corresponding pictures of the top and cross-sectional SEM images after coverage with graphene are depicted in Fig. 4(a) and (b). The graphene sheets are uniformly distributed on the sidewalls of the silicon MCP and the whole structure remains isolated and parallel to one another. The surface

![Fig. 2](image1.png)

*Fig. 2.* (a) SEM image of few-layer graphene; (b) AFM image of few-layer graphene; (c) Statistical thickness distribution histograms of the graphene nanosheets.

![Fig. 3](image2.png)

*Fig. 3.* (a) Photograph of Si-MCP; (b) SEM image of Si-MCP; (c) and (d) Corresponding magnified pictures of the top and cross-section of the Si-MCP.
of the channels becomes rougher. After deposition, there is an additional layer composed of numerous plate-like grains evenly distributed on the outer and inner sidewalls of Si-MCP. The graphene layer consists of many plate-like grains several to hundreds of nanometers in size supported by the Si-MCP producing an ordered graphene/Si-MCP array. The plate-like grains are interconnected and interwined with each other giving rise to a nanoporous graphene/Si-MCP array with a large surface area and short diffusion distance. The microstructure and morphology before and after deposition are similar.

Fig. 4(c) shows the Raman spectra of graphene/Si-MCP, natural graphite, graphene/Si-MCP-300 °C and graphene/Si-MCP-500 °C. The Raman spectra of graphene/Si-MCP shows a clear G-band at 1582 cm⁻¹ and 2D band at 2702 cm⁻¹. The 2D band location is different from that of natural graphite (located at 2721 cm⁻¹) and is more intense than that of graphite. The D-band at 1350 cm⁻¹ is caused by edge effects and the intensity of the G peak is not much larger than that of the D peak, indicating there are more defects which may favor application. The higher relative intensity and the decreased Raman frequency shifts of the 2D band indicate decreased graphene layers as consistent with AFM. After annealing at 300 °C, the D band decreases and the G peak is larger than the D peak while the 2D band is still absent. After annealing at 500 °C, the D band is again intense but the 2D band is still absent similar to graphene oxide. Fig. 4(d) shows the X-ray photoelectron spectroscopy (XPS) spectra of the graphene/Si-MCP, graphene/Si-MCP-300 °C, and graphene/Si-MCP-500 °C. The C1s and O1s signals are observed at 284 and 530 eV and the oxygen content in graphene/Si-MCP-300 °C is the smallest among the three samples. Fig. 4(e) presents the high-resolution C1s spectra of graphene/Si-MCP, graphene/Si-MCP-300 °C, and graphene/Si-MCP-500 °C, which can be fitted with three Gaussian peaks at 284.1, 285.5, and 288.0 eV.
attributed to sp² C (C–C=C=C), sp³ C(C–O), and oxidized C (C=O), respectively. Graphene/Si-MCP shows a strong peak of C=C suggestion good graphitization and the absence of oxygen-containing functional groups. After annealing at 300 °C for 1 h, the sample exhibits a strong peak for oxidized C and the peak intensity decreases substantially indicating that the amount of oxygen-containing functional groups is significantly reduced after the thermal treatment. After annealing at 500 °C, the amount of oxygen-containing functional groups increases giving rise to graphene oxide.

Cyclic voltammetry (CV) is conducted to analyze the reaction kinetics of the I⁺/I₃ couple on the counter electrode. Fig. 5 show the CVs of the counter electrodes of graphene/Si-MCP, graphene/Si-MCP-300 °C, and graphene/Si-MCP-500 °C at a scanning rate of 50 mV s⁻¹. Two pairs of redox peaks are observed. The one at the low potential can be attributed to the redox reaction in reaction (1) and that at the high potential to reaction (2) [20] as shown in the following:

\[ I₃^- + 2e^- \rightarrow 3I^- \quad (1) \]

\[ 3I₂ + 2e^- \rightarrow 2I₃^- \quad (2) \]

The peak current and peak-to-peak separation (ΔE_p) are two important parameters to comparing the catalytic activity of different counter electrodes. The larger the peak current density and the smaller the ΔE_p value, the better is the catalytic activity. Graphene/Si-MCP-300 °C shows the largest current density and smallest ΔE_p. The increase in the peak current density in triiodide reduction indicates good electrocatalytic activity towards reduction of I₃⁻ to I⁻. According to Nicholson, ΔE_p varies inversely with the charge transfer rate (kₜ, electrochemical rate constant of the redox reaction) and so the minimum ΔE_p indicates the highest kₜ [21]. The larger peak current density and smaller ΔE_p reveal that graphene/Si-MCP-300 °C is a better choice for reduction of I₃⁻. The CV curves of graphene/Si-MCP annealed at 300 °C in the I⁺/I₃ system at different scanning rates are shown in Fig. 6 and the inset illustrates the dependence of the current density of the I⁺/I₃ reduction peaks to the scanning rate. The linear relationship between the redox peak current density and square root of the scanning rate indicates that it is a controlled by ion diffusion in the electrolyte and may be related to the transport of the I⁺/I₃ couple away from the graphene/Si-MCP-300 °C electrode surface, further implying easy penetration and diffusion as well as a large number of reduction sites on the graphene/Si-MCP-300 °C structure.

Fig. 6. Cyclic voltammograms of graphene/Si-MCP-300 °C in the I⁺/I₃ system at different scanning rates (Inset: Dependence of the current density of the I⁺/I₃ reduction peaks on the scanning rate).

Graphite/Si-MCP shows a strong peak of C and the peak intensity decreases substantially indicating that the amount of oxygen-containing functional groups is significantly reduced after the thermal treatment. After annealing at 300 °C, the amount of oxygen-containing functional groups increases giving rise to graphitization.

In general, the quality of the catalytic electrode is characterized by the charge transfer resistance at the electrolyte-counter electrode interface. R_CT and it varies inversely with the current density, \( j_0 \):

\[ j_0 = \frac{RT}{nFRC_T} \quad (3) \]

In this relationship, \( R \) is the universal gas constant, \( T \) is the
absolutely temperature. $F$ is the Faraday constant, and $n$ is the stoichiometric number of electrons involved in the reaction. A smaller $R_t$ implies more efficient electron exchange at the interface of the electrolyte. As shown in Fig. 7, $R_t$ of graphene/Si-MCP-300 °C is 7.8 Ω and it is similar to that of the FTO/Pt electrode (11.39 Ω). $R_t$ of graphene/Si-MCP-300 °C is smaller than that of the Pt counter electrode showing high electrocatalytic activity [25-28].

Fig. 8 shows the photocurrent-voltage (J-V) characteristics of the DSSCs composed of the graphene/Si-MCP-300 °C, and graphene/Si-MCP-500 °C counter electrodes. Table 1 shows the corresponding data from the current-voltage characteristics under simulated solar irradiation (AM 1.5G, 100 mW cm$^{-2}$). For the DSSC fabricated with graphene/Si-MCP-300 °C counter electrode, the open circuit voltage (Voc), current density (Jsc), fill factor (FF), and conversion efficiency ($\eta$) are 737.43 mV, 15.18 mA-cm$^{-2}$, 0.50, and 7.16%, respectively. The current density of graphene/Si-MCP-300 °C is larger than those of graphene/Si-MCP and graphene/Si-MCP-500 °C.

4. Conclusion

An ordered graphene/Si-MCP counter electrode is prepared by conventional microelectronics fabrication techniques and electro-phoresis. The graphene/Si-MCP with a large surface area and defect-rich surface shows a small charge transfer resistance and delivers excellent photovoltaic performance. Owing to the microelectronics-compatible fabrication process, the materials have large potential in commercial energy storage devices.

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